	Application No.	Applicant(s)
	10/617,322	DINAN ET AL.
Notice of Allowability	Examiner	Art Unit
	Tianjie Chen	2627
The MAILING DATE of this communication apper All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this app or other appropriate communication IGHTS. This application is subject to	olication. If not included will be mailed in due course. THIS
1. This communication is responsive to <u>amendment filed on 0</u>	03/27/2006.	
2. The allowed claim(s) is/are <u>19-26 and 28-30</u> .		
3. Acknowledgment is made of a claim for foreign priority un a) All b) Some* c) None of the:		
1. Certified copies of the priority documents have been received.		
2. Certified copies of the priority documents have been received in Application No		
3. Copies of the certified copies of the priority documents have been received in this national stage application from the		
International Bureau (PCT Rule 17.2(a)). * Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file a reply of this communication.	complying with the requirements
4. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give	itted. Note the attached EXAMINER' es reason(s) why the oath or declarat	S AMENDMENT or NOTICE OF tion is deficient.
5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.		
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached		
1) ☐ hereto or 2) ☐ to Paper No./Mail Date		
(b) including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or in the O	ffice action of
identifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the	84(c)) should be written on the drawin ne header according to 37 CFR 1.121(d	gs In the front (not the back) of i).
6. DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT I	sit of BIOLOGICAL MATERIAL INFORTHE DEPOSIT OF BIOLOGICA	nust be submitted. Note the AL MATERIAL.
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Attachment(s)		
1. Notice of References Cited (PTO-892)	_	atent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. ⊠ Interview Summary (Paper No./Mail Date	(PTO-413),
 Information Disclosure Statements (PTO-1449 or PTO/SB/08 Paper No./Mail Date 	8), 7. 🛭 Examiner's Amendm	nent/Comment
Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. X Examiner's Statement	nt of Reasons for Allowance
	9. Other	11
		Che Longe
		TIANJIE CHEN PRIMARY EXAMINER

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EXAMINER'S AMENDMENT

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1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Robert O. Guillot on 06/08/2006.

The application has been amended as follows:

- In claim 19, line 5; "includes overhang portions" have been changed to
 --includes an overhang portion--, respectively.
- In claim 19, line 5; "said overhang portions" have been changed to --said overhang portion--, respectively.
- In claim 19, lines 7, 8, and 10; "portions" has been changed to --portion--, respectively.
- In claim 19, line 5; "project" has been changed to --projects--.
- In claim 19, line 7; "include" has been changed to --includes--.
- In claim 25, line 9; "includes overhang portions" have been changed to --includes an overhang portion--, respectively.
- In claim 25, line 9; "said overhang portions" have been changed to
 --said overhang portion--, respectively.
- In claim 25, lines 11, 12, and 14; "portions" has been changed to --portion--, respectively.
- In claim 25, line 9; "project" has been changed to --projects--.
- In claim 25, line 11; "include" has been changed to --includes--.
- In claim 28, line 1; "27" has been changed to --25--.

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REASONS FOR ALLOWANCE

- 2. The following is an examiner's statement of reasons for allowance:
 - With regard to independent claims 19 and 25, as the closest reference on record Terunuma et al (US 5,936,812) discloses a thin film device in Fig. 2 including: at least one thin film layer, at least one component above; the component including central portion that projects generally upwardly from the thin film laver; the component being formed with an over head that includes overhang portion wherein the overhang portions projects generally laterally outward from the central portion and over the thin film layer; and wherein the overhang portion includes an outer edge thereof; a layer being disposed beneath the overhang portions; the layer being disposed within a volume defined by the thin film laver, the central portion of the component, the overhang portion; but fails to show that the layer is photoresist and a surface that is generally perpendicular to the thin film layer and which surface intersects the outer edge of the overhang portion.
 - Applicant asserts: "the device is baked, such that hard baked resist remains beneath the overhang. Ultimately, the device is encapsulated and no voids or redeposition problems exist beneath the overhang due to the presence of the hard baked resist" (Specification, p. 3).

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

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3. Any inquiry concerning this communication or earlier communications

from the examiner should be directed to Tianjie Chen whose telephone number

is 571-272-7570. The examiner can normally be reached on 8:00-4:30, Mon-

Fri.

If attempts to reach the examiner by telephone are unsuccessful, the

examiner's supervisor, Hoa Nguyen can be reached on 571-272-7579. The fax

phone number for the organization where this application or proceeding is

assigned is 571-273-8300.

Information regarding the status of an application may be obtained from

the Patent Application Information Retrieval (PAIR) system. Status information

for published applications may be obtained from either Private PAIR or Public

PAIR. Status information for unpublished applications is available through

Private PAIR only. For more information about the PAIR system, see

http://pair-direct.uspto.gov. Should you have questions on access to the

Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-

9197 (toll-free). If you would like assistance from a USPTO Customer Service

Representative or access to the automated information system, call 800-786-

9199 (IN USA OR CANADA) or 571-272-1000.

Chen franzie TIANJIE CHEN

PRIMARY EXAMINER

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